Docket No.: 60188-700 **PATENT**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Toyoji ITO, et al. : Confirmation Number:

Serial No.: : Group Art Unit:

Filed: November 13, 2003 : Examiner:

For: SEMICONDUCTOR DEVICE AND METHOD FOR FABRICATING THE SAME

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The relevance of Japanese Laid-Open Publication No. 2001-237393 and Japanese Laid-Open Publication No. 11-126881, are discussed in the present specification.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

Michael E. Fogarty Registration No. 36,139

600 13th Street, N.W. Washington, DC 20005-3096 (202) 756-8000 MEF:gav Facsimile: (202) 756-8087

Date: November 13, 2003

								SITE	<u> </u>	
INFC	AT	ON DISCLOSTION IN AN LICATION	SURE	ATTY. DOCKET NO. SER 60188-700			RIAL NO.			
					APPLICANT Toyoji ITO, et al.					
	(PT	O-1449)		FILING DATE November 13, 2	FILING DATE GROUP November 13, 2003					
				U.S. PATE	NT DOCUMENTS		<u> </u>		 -	
EXAMINER'S	MINER'S Document Number Publication Date				Name of Patentee or Applicant of Cited			Pages, Columns, Lines, Where		
INITIALS	CITE NO.	Number-Kind Code2 (# known)		MM-DD-YYYY		Document Document		Relevant Passages or Relevant Figures Appear		
		US	S 6,249,014 B1 06/19/2001 Bailey			 				
		US								
	i -	US								
	1	US								
	•	US								
	i -	US								
		US								
		US								
		US								
		US								
		US								
		US								
		US						-		
	US									
FOREIGN PATENT DOCUMENTS										
EXAMINER'S INITIALS CITE NO.		Foreign Patent Document Country Codes -Number 4-Kind Codes (if known)		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Line Where Relevar Figures Appea			
	<u> </u>	L						Yes	No	
			JP 11-8355 A	01/12/1999	NEC CORP.			JAPAN (w/ English Abstract)		
			JP 11-126881 A	05/11/1999	HITACHI LTD.			JAPAN (w/ English Abstract)		
			JP 2001-237393 A	08/31/2001	INFINEON TECHNOLOG AG	IES		JAPAN (w/ English Abstract)		
	†			<u> </u>	<u> </u>	\neg	**			
		†		<u> </u>	 	$\neg \uparrow$				
	•		OTHER A	RT (Including Auth	or, Title, Date, Pertinent Pag	es, Etc	;.)			
EXAMINER'S INITIALS Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.									е,	
		Ī						18 1		
		1								
EXAMINER						DATE CONSIDERED				

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.